

Search Notes

Application/Control No.

10/572,711

Examiner

YONG PAK

Applicant(s)/Patent under
Reexamination

BOGOSIAN ET AL.

Art Unit

1652

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
stic: seq id no:2 and 4, see SCORE	5-20-2011	YP
EAST (all databases): inventor & text search, see search history	5-20-2011	YP
PALM: inventor search	5-20-2011	YP